

Notice of References Cited

Application/Control No.

10/519,339

Applicant(s)/Patent Under
Reexamination
MIYAGAWA ET AL.

Examiner

KHANH T. NGUYEN

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,522,523	02-2003	Takatomi et al.	361/502
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-124265	04-2002	JP	Sakamoto et al.	H01M 4/68
	O	JP 2001-168573	06-2001	JP	Ishihara, Natsuko	H05K 9/00
	P	JP 09-2008313	08-1997	JP-Abstract	Toshiro et al.	C04B 35/52
	Q	JP 09-107195	04-1997	JP-Abstract	Obayashi et al.	H05K 9/00
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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